

V9 NO CLEAN SOLDER PASTE

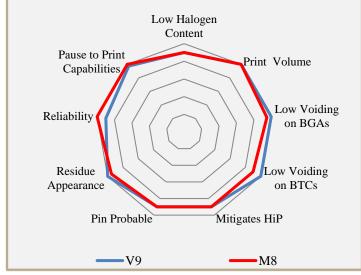
FEATURES

- Low-Voiding: as low as 1% on BGA and <5% on BTCs</p>
- Capable of Consistent Printing with Area Ratio < 0.66
- High Reliability (SIR)
- Drop-in for M8
- REACH and RoHS* Compliant
- Available in SAC305 T4

CHARACTERISTICS

DESCRIPTION

V9 Low-Voiding No Clean solder paste is formulated for near-zero voiding on BGA, BTC and LED soldering applications. Significant void reduction achievable on all surface finishes including ENIG, ImSn and OSP. V9 exhibits stable print performance on fine feature devices over 12 hours. V9 post-process residue is easily pin-probed and has high SIR values.



*Lead-free alloys.

HANDLING & STORAGE

| PARAMETER | TIME | TEMPERATURE |
|-----------------------|----------|----------------------|
| Sealed Refrigerated | 6 Months | 0°C-12°C (32°F-55°F) |
| Shelf Life | | |
| Sealed Unrefrigerated | 1 Month | < 25°C (< 77°F) |
| Shelf Life | | |

Do not add used paste to unused paste. Store used paste separately; keep unused paste tightly sealed with internal plug or end cap in place. After opening, solder paste shelf life is environment and application dependent. See AIM's paste handling guidelines for further information. Alloy and storage conditions may affect shelf life. Please refer to V9 Certificate of Analysis for product specific information.

CLEANING

Pre-Reflow: AIM DJAW-10 effectively removes V9 solder paste from stencils while in process. DJAW-10 can be hand applied or used in under stencil wipe equipment. DJAW-10 will not dry V9 and will enhance transfer properties. Do not over-apply DJAW-10. Do not apply DJAW-10 to stencil topside. Isopropanol (IPA) is not recommended in process, but may be used as a final stencil rinse.

Post-Reflow Flux Residue: V9 residues can remain on the assembly after reflow and do not require cleaning. Where cleaning is mandated, AIM has worked closely with industry partners to ensure that V9 residues can be effectively removed with common defluxing agents. Contact AIM for cleaning compatibility information.

*All information for reference only. Not to be used as incoming product specifications or for process design. Consult Certificate of Analysis for product specific information.



REFLOW PROFILE

Detailed profile information may be found at <u>http://www.aimsolder.com/reflow-profile-supplements</u>. Contact AIM for additional information.

PRINTING

| RECOMMENDED INITIAL PRINTER SETTINGS - DEPENDENT ON PCB AND PAD DESIGN | | |
|--|------------------------------|--|
| Parameter | Recommended Initial Settings | |
| Squeegee Pressure | 0.4 - 0.7kg/25mm | |
| Squeegee Speed | 13 – 152 mm/second | |
| Snap-off Distance | On Contact 0.00 mm | |
| PCB Separation Distance | 0.75 - 2.0 mm | |
| PCB Separation Speed | 3 - 20 mm/second | |

TEST DATA SUMMARY

| NAME | TEST METHOD | | RESULTS |
|---|--|----------------------------------|--------------------------|
| IPC Flux Classification | J-STD-004 3.3 | ROL0 | |
| IPC Flux Classification | J-STD-004B 3.3 | ROL1 | |
| NAME | TEST METHOD | TYPICAL RESULTS | IMAGE |
| Copper Mirror | J-STD-004B 3.4.1.1 IPC-TM-650 2.3.32 | LOW | V9 P-14816 CONTROL |
| Corrosion | J-STD-004B 3.4.1.2 IPC-TM-650 2.6.15 | PASS | Before After |
| Quantitative Halides | J-STD-004B 3.4.1.3 IPC-TM-650 2.3.28.1 | Br: 0.44% Cl: 0.0% Typical | |
| Qualitative Halides, Silver Chromate | J-STD-004B 3.5.1.1 IPC-TM-650 2.3.33 | PASS | |
| Qualitative Halides, Fluoride Spot | J-STD-004B 3.5.1.2 IPC-TM-650 2.3.35.1 | PASS | |

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TECHNICAL DATA SHEET



| NAME | TEST METHO D | TYPICAL RESULTS | IMAGE | |
|--|--|---|---|--|
| Surface Insulation Resistance | J-STD- 004B 3.4.1.4 IPC-TM- 650 2.6.3.7 | All measurements on test patterns exceed 100 MΩ | 13.00 12.00 10.00 10.00 9.00 8.00 7.00 6.00 5.00 4.00 3.00 0 1 2 3 4 5 6 7 Time, day 10 9 SAC305 1A 10 9 SAC305 1B 10 9 SAC305 | |
| Flux Solids, Nonvolatile Determination | J-STD- 004B 3.4.2.1 IPC-TM- 650 2.3.34 | 94.14% Typical | | |
| Acid Value Determination | J-STD- 004B 3.4.2.2 IPC-TM- 650 2.3.13 | 139.03 mg KOH/g Typical | | |
| Viscosity (Malcom) | J-STD- 005A 3.5.1 IPC-TM- 650 2.4.34 | 130-200 Pa·s Typical | | |
| Visual | J-STD- 004B 3.4.2.5 | PASS | | |
| Slump | J-STD- 005A 3.6 IPC-TM- 650 2.4.35 | PASS | | |

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TECHNICAL DATA SHEET



| NAME | TEST METHOD | TYPICAL RESULTS | IMAGE |
|-------------|---|------------------------------|--|
| Spread Test | J-STD- 004B 3.7.2 IPC-TM- 650 2.4.46 | PASS | |
| Solder Ball | J-STD- 005A 3.7 IPC-TM- 650 2.4.43 | PASS | 15 min 4 hrs |
| Tack | J-STD- 005A 3.8 IPC-TM- 650 2.4.44 | 36.1 gf Time 0 Typical | 100 100 100 100 100 100 100 100 |
| Tack | JIS Z 3284 Annex 9 | 82.5 gf Time 0 Typical | JIS SAC305 V9 88.5T4 |

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